

Notice of References Cited

Application/Control No.

10/599,243

Applicant(s)/Patent Under
Reexamination
TAMAKI ET AL.

Examiner

Benjamin M. Baldrige

Art Unit

2831

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,242,930 B1 | 06-2001 | Matsunaga et al. | 324/754 |
| * | B | US-2001/0017549 A1 | 08-2001 | Inoue et al. | 324/754 |
| * | C | US-6,617,864 B2 | 09-2003 | Inoue et al. | 324/754 |
| * | D | US-6,970,001 B2 | 11-2005 | Chheda et al. | 324/649 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.